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|-----------------------------------|---------------------------------------|--|---|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/742,695 |  | Applicant(s)/Patent Under<br>Reexamination<br>QADEER ET AL. |             |
|                                   | Examiner<br>SAIF A. ALHIJA            |  | Art Unit<br>2128  | Page 1 of 1 |

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| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name | Classification |
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#### FOREIGN PATENT DOCUMENTS

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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